Applicant(s)/Patent Under Application/Control No. Reexamination 10/567,685 SUGIYAMA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2169 Ajith Jacob **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY 705/7 * US-2002/0065693 A1 05-2002 Hattori et al. Α US-В US-С US-D US-Ε US-F US-G US-Н US-US-US-Κ US-US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Classification Name Country Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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